

MEASUREMENT/TECHNICAL REPORT

Challenger, Division of Wayne Dalton - Model: IRF 01-3036 Rev. 1
FCC ID: FON01-3036
April 1998

This report concerns (check one:) Original Grant _____ Class II Change X

Equipment Type: Transmitter (example: computer, printer, modem, etc.)

Deferred grant requested per 47 CFR 0.457(d)(1)(ii)? Yes _____ No X

If yes, defer until: _____
date

Company Name agrees to notify the Commission by: _____
date

of the intended date of announcement of the product so that the grant can be issued on that date.

Transition Rules Request per 15.37? Yes _____ No X

If no, assumed Part 15, Subpart B for unintentional radiator - the new 47 CFR [10-1-96 Edition] provision.

Report prepared by: _____
Andrew J. Bellezza
Intertek Testing Services NA Inc.
593 Massachusetts Avenue
Boxborough, MA 01719
Phone: 978-263-2662
FAX: 978-263-7086

Martec Engineering Notice number 001083

Project Number: 01-3036 ver I0
Initiated By: M.B.

Description: IRF
Date: 04/01/98

Description of Change:

file name: - CH001083

1. Strip the copper under the antenna loop.

Reason for change:

1. Better RF transmitter performance.
Transmitter is tuned to 303MHz as the earlier F0 version.
2. All timing (microprocessor) is derived from 12MHz oscillator.

Approved By :

Engineering:

Marketing:

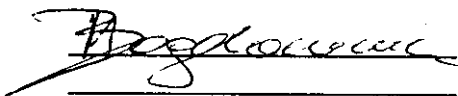
Quality:

Materials:

Manufacturing:

Designer:

Other:



Send to:

Intertek J. Zarnowiec
Challenger R Wood

Old Drawing

New Drawing

Artwork 38-3036 ver F	Artwork 38-3036 ver I
Bill of material 02-3036 ver F0.A	Bill of material 02-3036 ver IO.A

Intertek Testing Services NA Inc.

1.2 Related Submittal(s) Grants

1.3 Test Methodology

Both AC mains line-conducted and radiated emission measurements were performed according to the procedures in ANSI C63.4 (1992). All measurements were performed in Open Area Test Sites. Preliminary scans were performed in the Open Area Test Sites only to determine worst case modes. For each scan, the procedure for maximizing emissions in Appendices D and E were followed. All Radiated tests were performed at an antenna to EUT distance of 3 meters, unless stated otherwise in the "**Justification Section**" of this Application.

1.4 Test Facility

The open area test site and conducted measurement facility used to collect the radiated data is located at 593 Massachusetts Avenue, Boxborough, Massachusetts. The East site was used. This test facility has been fully described in a report dated November 20, 1996 submitted to your office. Please reference the site filing number: 31040/SIT 1300F2, dated January 16, 1997. Each test site is accredited by the NVLAP program.

Intertek Testing Services NA Inc.

EXHIBIT 2
SYSTEM TEST CONFIGURATION

2.0 System Test Configuration

2.1 Justification

The transmitter was configured for testing in a typical fashion (as a customer would normally use it). The device was mounted to a cardboard box, which enabled the engineer to maximize emissions through its placement in the three orthogonal axis.

The device was powered from a new, fully charged 4.5 V battery.

For simplicity of testing, the unit was wired to transmit continuously.

The worst case bit sequence was applied during test.

2.2 EUT Exercising Software

The EUT exercise program used during radiated and conducted testing was designed to exercise the various system components in a manner similar to a typical use.

Intertek Testing Services NA Inc.

2.3 Equipment Modification

A list of changes made to the product since original grant of equipment authorization is included in Exhibit 1 of this application.

Any modifications installed previous to testing by Challenger, Division of Wayne Dalton will be incorporated in each production model sold/leased in the United States.

Confirmed by:

*Andrew J. Bellezza
Engineering Team Leader, ITE
Intertek Testing Services NA Inc.
Agent for Challenger, Division of Wayne Dalton*

Andrew J. Bellezza Signature

4-17-98 Date

Intertek Testing Services NA Inc.

2.4 Support Equipment List and Description

The FCC ID's for all equipment, plus descriptions of all cables used in the tested system (included inserted cards, which have grants) are:

Not Applicable

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EXHIBIT 3
EMISSION RESULTS

3.0 **Emission Results**

Data is included of the worst case configuration (the configuration which resulted in the highest emission levels). A sample calculation, configuration photographs, data tables and graphical representations of the emissions are included.

3.1 Field Strength Calculation

The field strength is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain (if any) from the measured reading. The basic equation with a sample calculation is as follows:

$$FS = RA + AF + CF - AG$$

where

- FS = Field Strength in $\text{dB}\mu\text{V}/\text{m}$
- RA = Receiver Amplitude (including preamplifier) in $\text{dB}\mu\text{V}$
- CF = Cable Attenuation Factor in dB
- AF = Antenna Factor in dB
- AG = Amplifier Gain in dB

In the following table(s), the reading shown on the data table reflects the preamplifier gain. An example for the calculations in the following table is as follows:

$$FS = RR + LF$$

where

- FS = Field Strength in $\text{dB}\mu\text{V}/\text{m}$
- RR = RA - AG in $\text{dB}\mu\text{V}$
- LF = CF + AF in dB

Assume a receiver reading of $52.0 \text{ dB}\mu\text{V}$ is obtained. The antenna factor of 7.4 dB and cable factor of 1.6 dB is added. The amplifier gain of 29 dB is subtracted, giving a field strength of $32 \text{ dB}\mu\text{V}/\text{m}$. This value in $\text{dB}\mu\text{V}/\text{m}$ was converted to its corresponding level in $\mu\text{V}/\text{m}$.

$$RA = 52.0 \text{ dB}\mu\text{V}/\text{m}$$

$$AF = 7.4 \text{ dB}$$

$$RR = 23.0 \text{ dB}\mu\text{V}$$

$$CF = 1.6 \text{ dB}$$

$$LF = 9.0 \text{ dB}$$

$$AG = 29.0 \text{ dB}$$

$$FS = RR + LF$$

$$FS = 23 + 9 = 32 \text{ dB}\mu\text{V}/\text{m}$$

$$\text{Level in } \mu\text{V}/\text{m} = \text{Common Antilogarithm } [(32 \text{ dB}\mu\text{V}/\text{m})/20] = 39.8 \mu\text{V}/\text{m}$$

3.2 Radiated Emission Configuration Photograph

Worst Case Radiated Emission

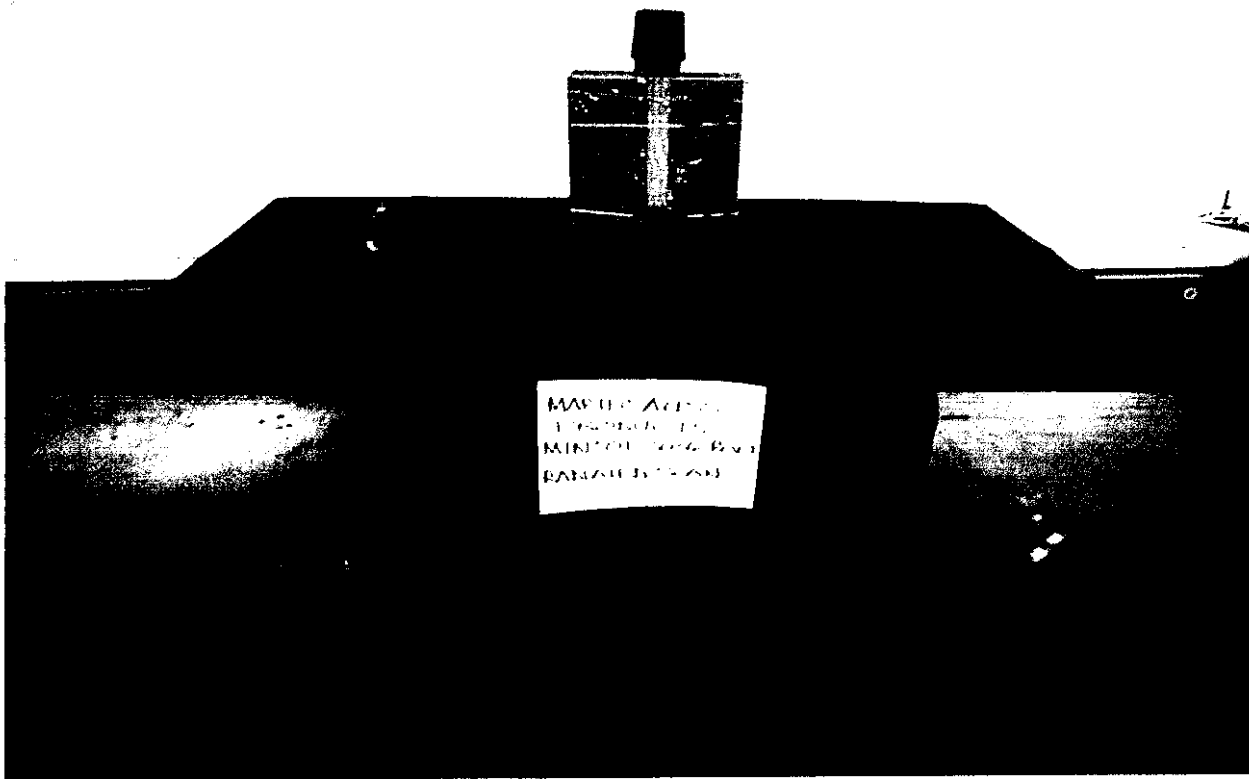
Front View

909.150 MHz

Intertek Testing Services NA, Inc.

Company:	Martec Access Products	Model:	01-3036 Rev-1
Date:	March 13, 1998	Engineer:	Kouma Sinn
Notes:			

Worst-Case Radiated Emissions Configuration



3.2 Radiated Emission Configuration Photograph (cont)

Worst Case Radiated Emission

Rear View

909.150 MHz

Intertek Testing Services NA Inc.

3.3 Radiated Emission Data

The data on the following page lists the significant emission frequencies, the limit and the margin of compliance. Numbers with a minus sign are below the limit.

Judgement: Passed by 2 dB

*All readings are peak unless stated otherwise

TEST PERSONNEL:

Andrew T. Bellego FOR KPS
Tester Signature

Kouma Sinn, Compliance Engineer
Typed/Printed Name

1-17-98
Date

Intertek Testing Services

Boxborough, MA

COMPANY: Martec Access Products
 MODEL: 01-3036 Rev-1

TABLE: 1
 Date of Test: 03-13-1998

NOTES: Radiated scan at 3 meters

Radiated Emissions

Frequency (MHz)	Reading (dBuV)	Distance Factor (dB)	Antenna Factor (dB)	Pre-Amp Gain (dB)	Averaging Factor (dB)	Pulse Desensitization (dB)	Field Strength @ 3 m (dBuV/m)	Field Strength @ 3 m (uV/m)	Limits @ 3 m (uV/m)	Margin (dB)
303.050	58	0	22	0	-11	0	69	2818	5630	-6
606.080	27	0	29	0	-11	0	45	178	563	-10
909.150	30	0	34	0	-11	0	53	447	563	-2
1212.000	37	0	24	0	-11	0	50	316	500	-4
1515.000	26	0	26	0	-11	0	41	112	500	-13
2121.000	18	0	30	0	-11	0	37	71	563	-18
2424.000	10	0	30	0	-11	0	29	28	563	-26
3030.000	5	0	34	0	-11	0	28	25	563	-27

No other harmonic or spurious emissions were detected at a test distance of 0.3 meter.

Test Engineer: Kouma Sinn

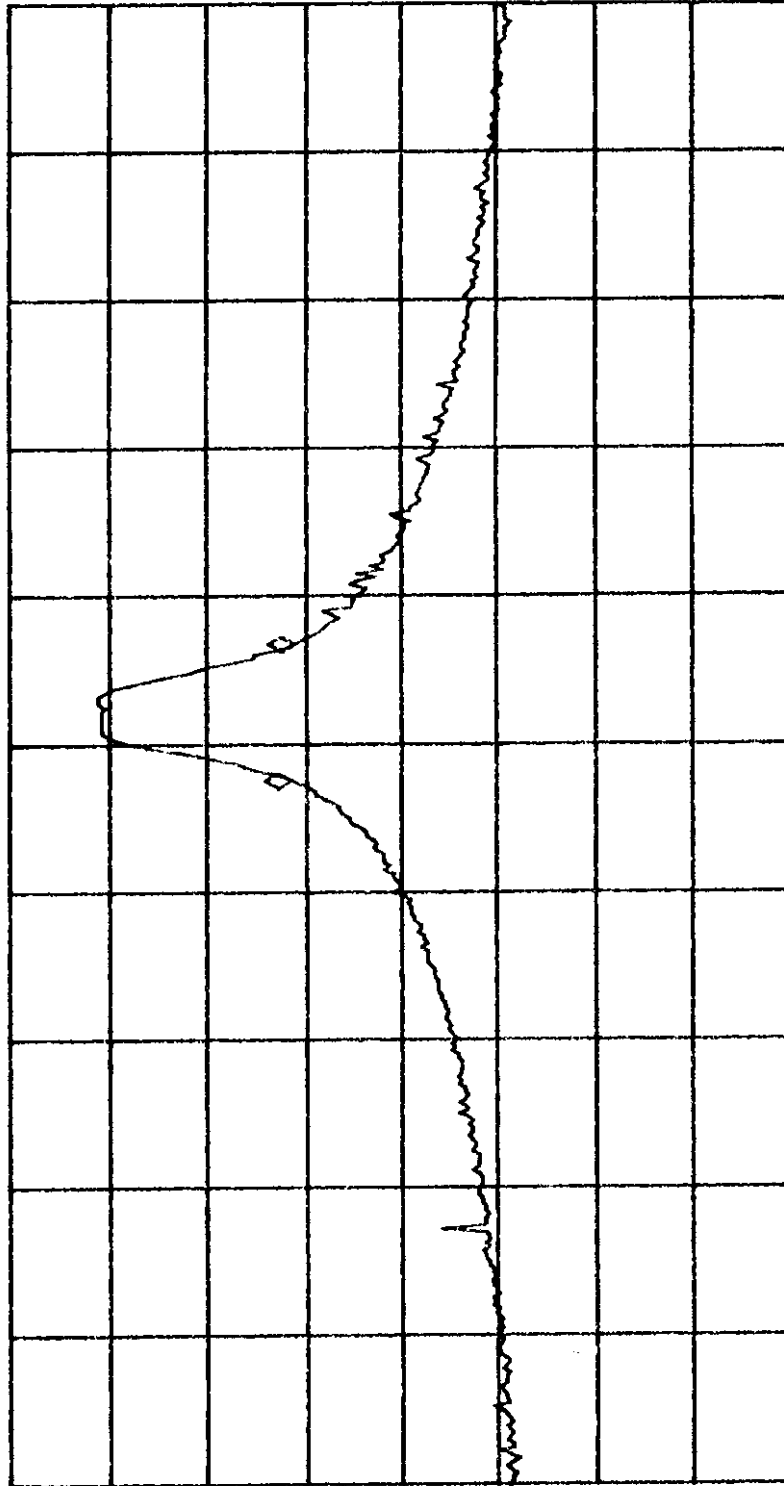
11:46:19 MAR 13, 1998

MARKER Δ
-185 kHz
.48 dB

ACTV DET: PEAK
MEAS DET: PEAK QP AVG
MKR Δ -185 kHz
.48 dB

LOG REF 60.0 dB μ V

10
dB/
#ATN
0 dB



CENTER 303.000 MHz
#IF BW 30 kHz

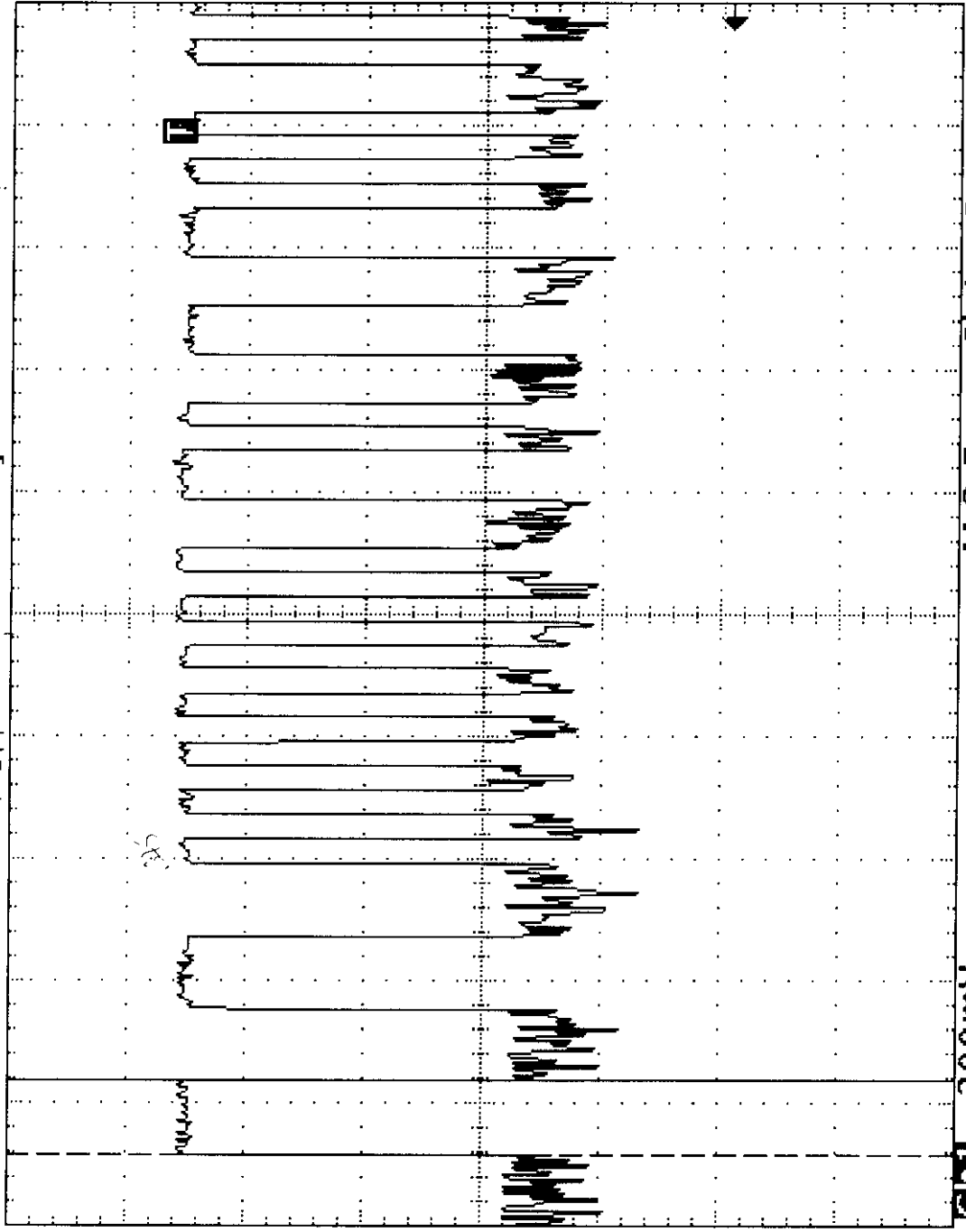
AVG BW 30 kHz

SPAN 2.000 MHz
#SWP 100 msec

Tek Stop 20KS/s

11 Acqs

[] T]



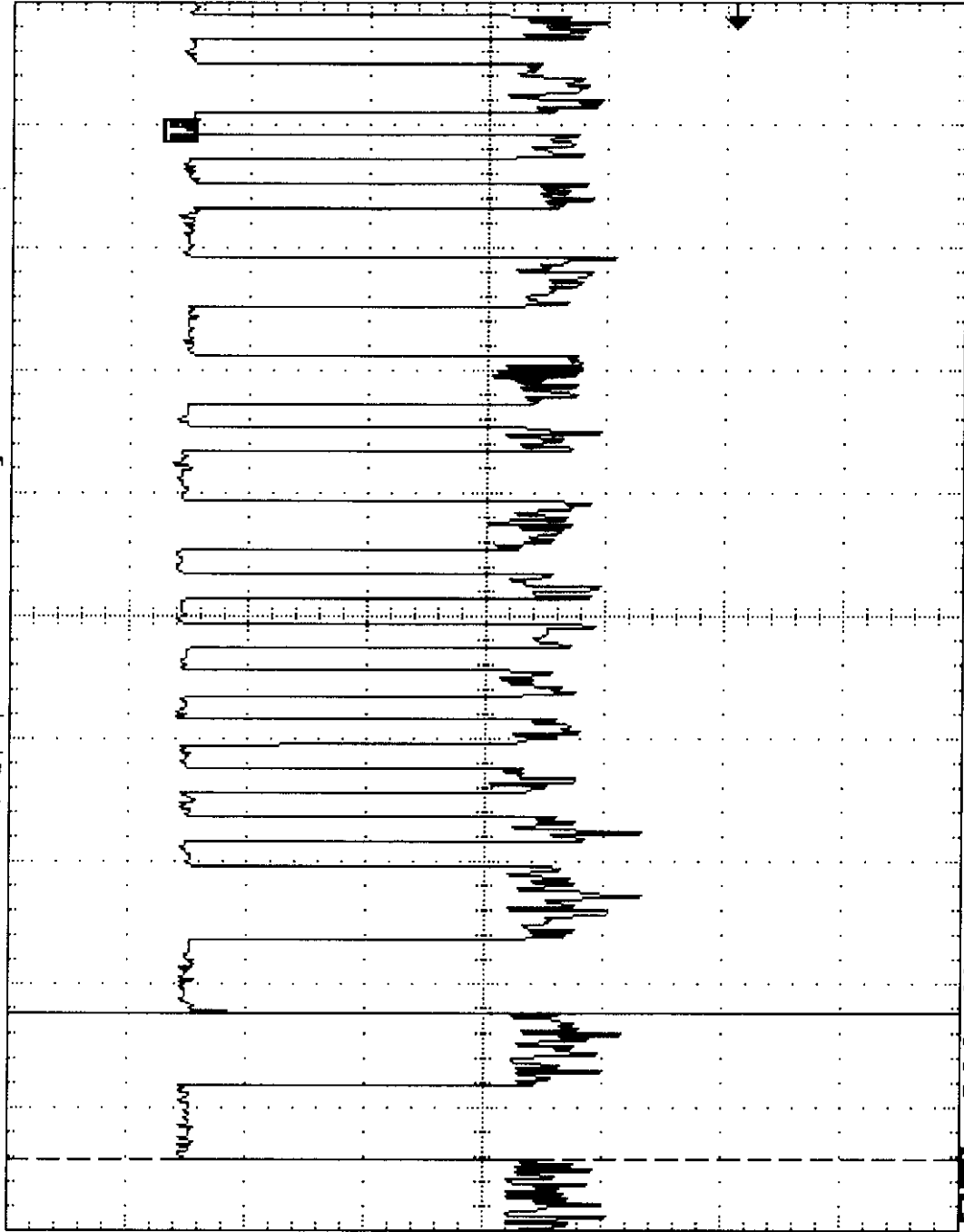
Δ: 1.5ms
@: -19.45ms

13 Mar 1998
13:42:51

Tek Stop 20ks/s

11 Acqs

[] T]



Δ : 2.95ms
@: -18ms

Ch1 200mV 500µs -48mV

Ref1 100mV

M 2.5ms

Ch1

-48mV

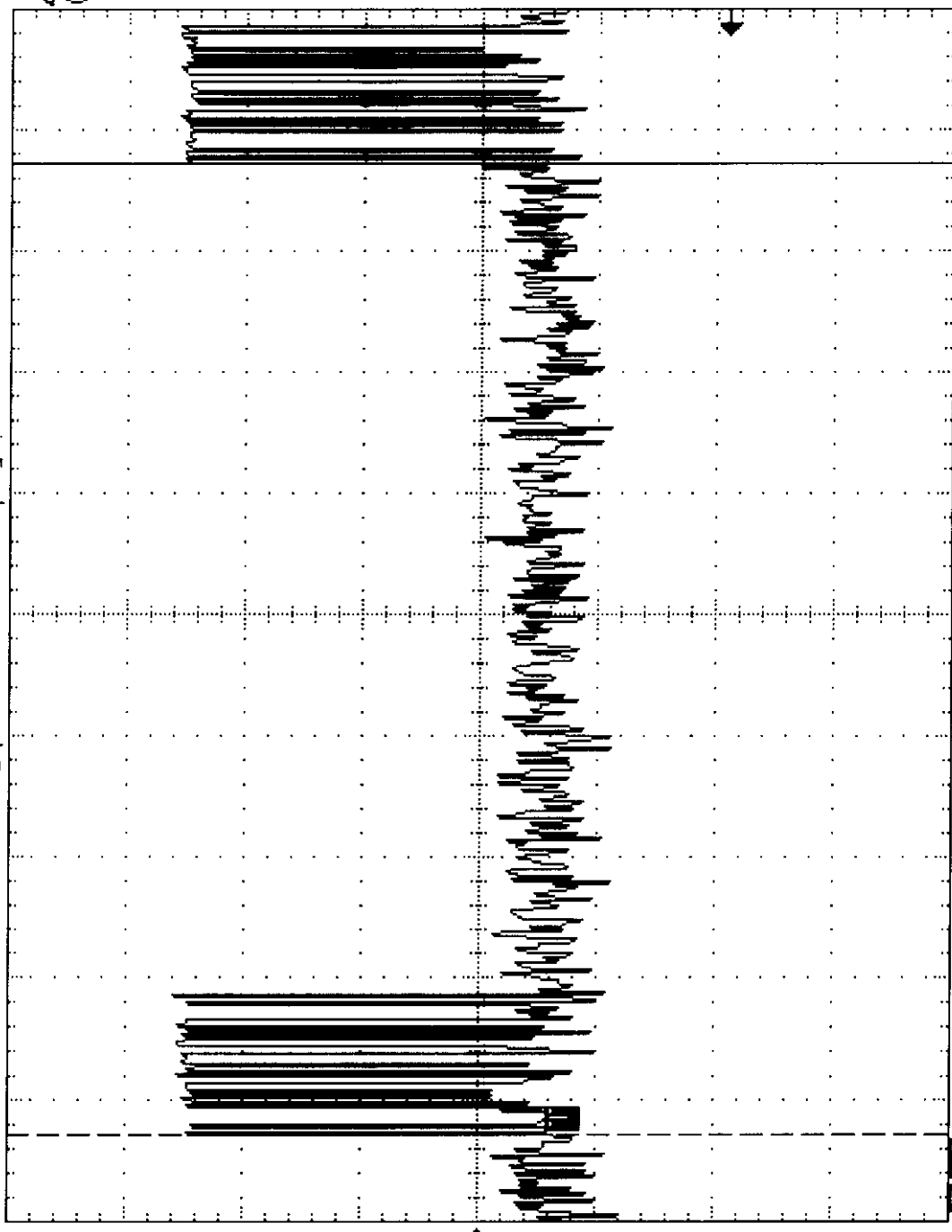
13 Mar 1998
13:45:06

Tek Stop: 1 kS/s

5 Acqs

[T]

Δ : 400ms
@: 393ms



R1 →

I →

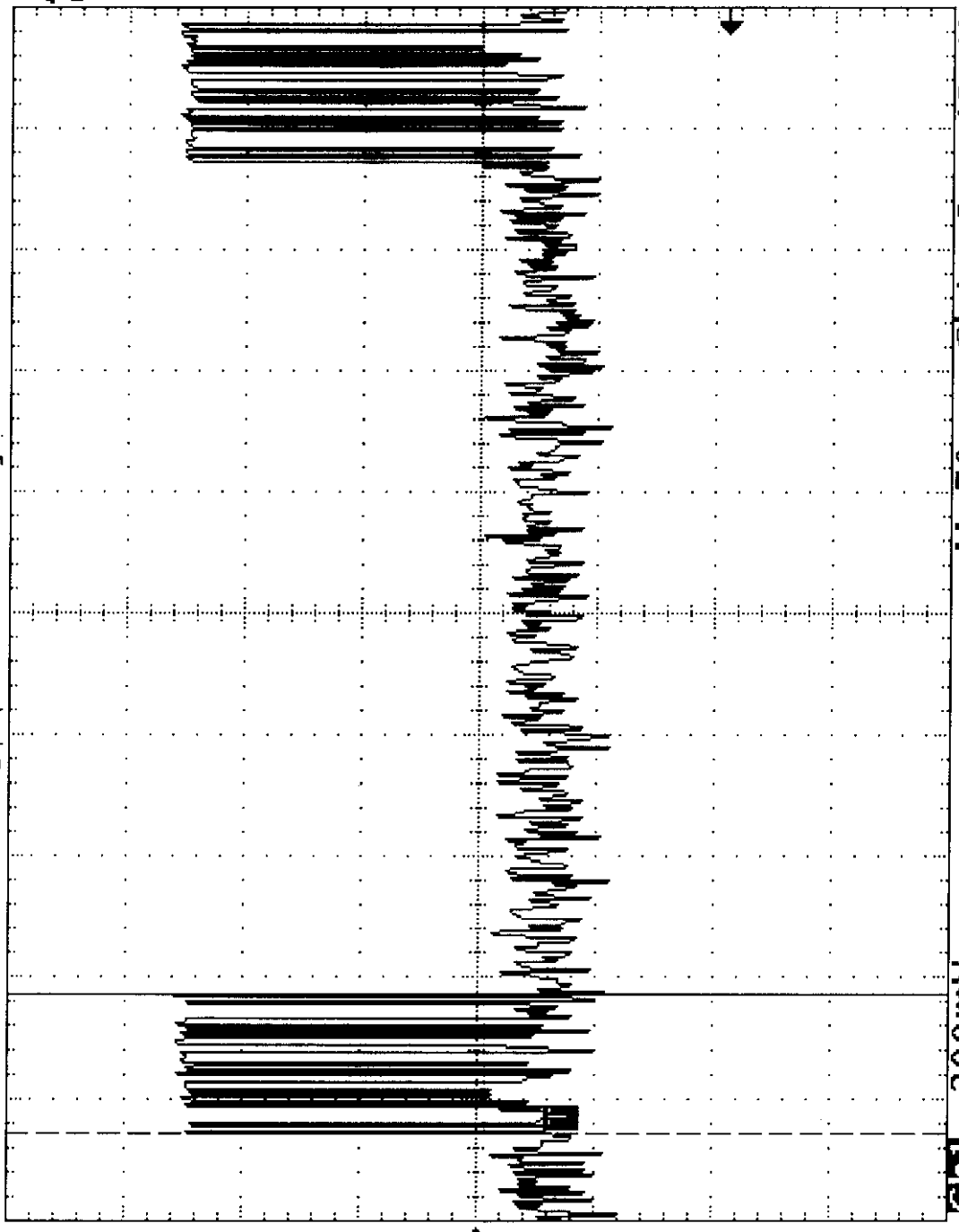
Ch1 200mV
Ref1 100mV
M 50ms Ch1 500μs
-48mV

13 Mar 1998
13:30:01

Tek Stop: 1 kS/s

5 Acqs

[T]



Δ : 57 ms
@: 50 ms

Ch1 200mV
Ref1 100mV
M 50ms Ch1 F -48mV
500 μ s

13 Mar 1998
13:26:55

EXHIBIT 4

EQUIPMENT PHOTOGRAPHS

4.0 **Equipment Photographs**

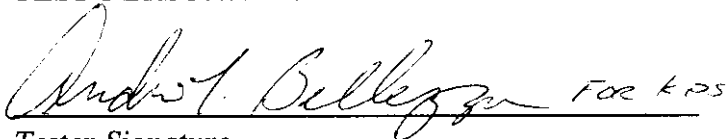
Photographs of the modifications made to the EUT (since original grant and during testing, if applicable) are attached.

Intertek Testing Services NA Inc.

3.4 Line Conducted Emission Configuration Data

No line-conducted emissions measurements were performed as the unit is battery powered.

TEST PERSONNEL:


Tester Signature

Kouma Sinn, Compliance Engineer
Typed/Printed Name

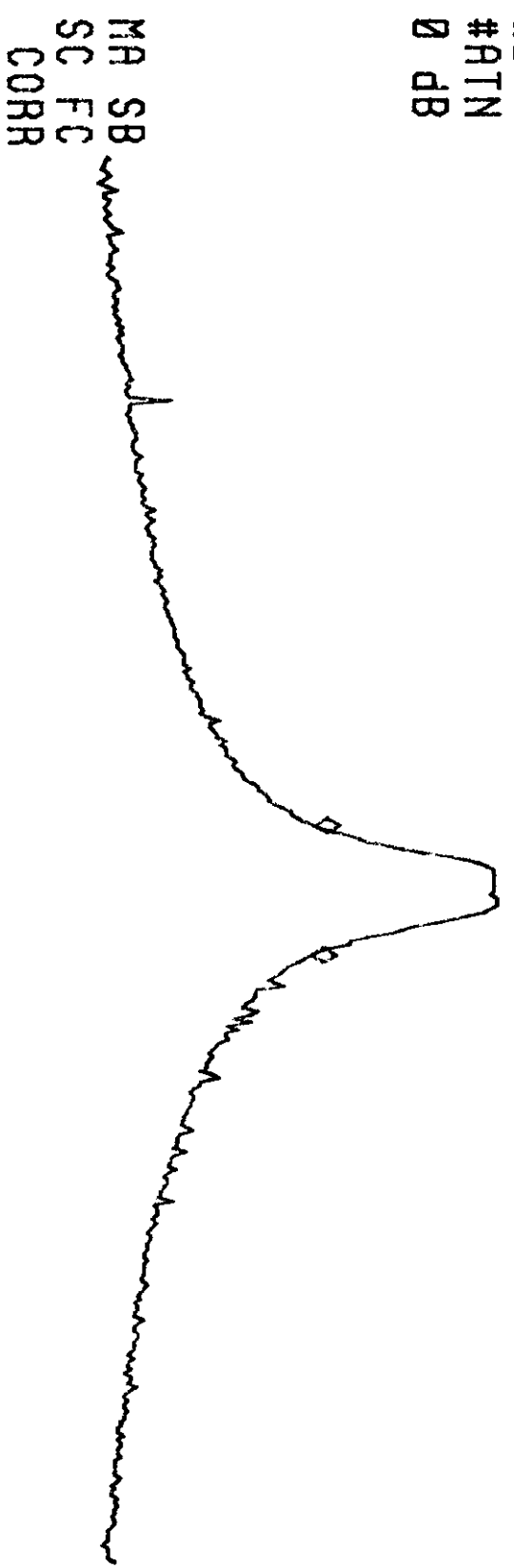
7-17-98
Date

11:46:19 MAR 13, 1998

MARKER Δ
-185 KHZ
.48 DB

ACTV DET: PEAK
MEAS DET: PEAK QP AVG
MKRA Δ -185 KHZ
.48 DB

LOG REF 60.0 DB μ V
10
DB/
#ATTN
0 DB



CENTER 303.000 MHZ
#IF BW 30 KHZ
AUG BW 30 KHZ
SPAN 2.000 MHZ
#SWP 100 msec